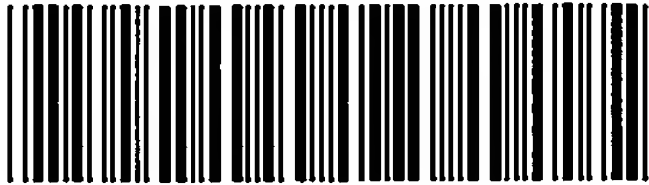


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/659,369	YANAGAWA ET AL.	
	Examiner	Art Unit	
	Mike Qi	2871	

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349	141,146 144,145 139,110 155	5/11/2005	ZQQ

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
East search	5/11/2005	ZQQ